MQX2 Hipot in Helium

Test Instruments Used

Test Model #	Test Serial #	Calibration Due Date
7550DT	9111100	02/01/2004

Test Date: 10/21/2004

Test Time: 03:52:14 AM

User Name: EGB 10/21/04

Device Tested

Model Number: LQX A thru F Voltage Taps IN HELIUM

Serial Number: Box G MQXZ

Setup Filename:

Results

	Test Type	Memory	Step	Pass/Fail	Test Result	Timer	Parameter 1	Parameter 2
1	DC Withstand A	26	1	Pass	Pass	60.0s	1.40KV	0.7microamps
2	DC Withstand B	26	2	Pass	Pass	60.0s	1.40KV	0.7microamps
3	DC Withstand C	26	3	Pass	Pass	60.0s	1.40KV	0.8microamps
4	DC Withstand D	26	4	Pass	Pass	60.0s	1.40KV	0.7microamps
5	DC Withstand E	26	5	Pass	Pass	60.0s	1.40KV	0.7microamps
6	DC Withstand F	26	6	Pass	Pass	60.0s	1.40KV	0.7microamps
~~7~~	~~AC Withstand~~	~~26~~	~~7~~	~~Pass~~	~~Pass~~	~~1.0s~~	~~1.20KV~~	~~0.000mA~~

Test Instruments Used

Test Model #	Test Serial #	Calibration Due Date
7550DT		03/17/1999

Test Date: 10/21/2004

Test Time: 08:09:34 PM

User Name: DJC 10/22/04

Device Tested

Model Number: LBX G thru L IN HELIUM

Serial Number: Box G MGX2

Setup Filename: Leads in Air & He..hsu

Results

	Test Type	Memory	Step	Pass/Fail	Test Result	Timer	Parameter 1	Parameter 2
1	DC Withstand G	27	1	Pass	Pass	60.0s	1.40KV	0.5microamps
2	DC Withstand H	27	2	Pass	Pass	60.0s	1.40KV	0.5microamps
3	DC Withstand I1-I4	27	3	Pass	Pass	60.0s	1.40KV	0.5microamps
4	DC Withstand J	27	4	Pass	Pass	60.0s	0.65KV	0.5microamps
5	DC Withstand K	27	5	Pass	Pass	60.0s	0.65KV	0.4microamps
6	DC Withstand L1-L2, I5-I6	27	6	Pass	Pass	60.0s	0.65KV	0.6microamps
~~7~~	~~AC Withstand~~	~~27~~	~~7~~	~~Fail~~	~~Hi Limit~~	~~0.2s~~	~~0.00KV~~	~~0.021mA~~
~~8~~	~~AC Withstand~~	~~27~~	~~8~~	~~Fail~~	~~Hi Limit~~	~~0.2s~~	~~0.00KV~~	~~0.021mA~~

Test Instruments Used

Test Model #	Test Serial #	Calibration Due Date
7550DT	9111100	02/01/2004

Test Date: 10/22/2004

Test Time: 12:39:03 AM

User Name: EB 10/21/04

Device Tested

Model Number: LQX RTD 1-12 IN HELIUM

Serial Number: Box G MQX2

Setup Filename:

Results

	Test Type	Memory	Step	Pass/Fail	Test Result	Timer	Parameter 1	Parameter 2
1	DC Withstand	32	1	Pass	Pass	60.0s	0.20KV	0.0microamps
~~2~~	~~AC Withstand~~	~~32~~	~~2~~	~~Fail~~	~~Abort~~	~~0.9s~~	~~1.20KV~~	~~0.000mA~~

Test Instruments Used

Test Model #	Test Serial #	Calibration Due Date
7550DT	9111100	02/01/2004

Test Date: 10/22/2004

Test Time: 12:43:45 AM

User Name: BB 10/21/04

Device Tested

Model Number: LQX RTD 13-24 IN HELIUM

Serial Number: Box G MQX2

Setup Filename:

Results

	Test Type	Memory	Step	Pass/Fail	Test Result	Timer	Parameter 1	Parameter 2
1	DC Withstand	32	1	Pass	Pass	60.0s	0.20KV	0.0microamps
~~2~~	~~AC Withstand~~	~~32~~	~~2~~	~~Fail~~	~~Abort~~	~~0.4s~~	~~0.74KV~~	~~0.000mA~~

Test Instruments Used

Test Model #	Test Serial #	Calibration Due Date
7550DT	9111100	02/01/2004

Test Date: 10/22/2004

Test Time: 12:47:31 AM

User Name: EZB 10/21/04

Device Tested

Model Number: LQX RTD 25-32 IN HELIUM

Serial Number: Box G MQX2

Setup Filename:

Results

	Test Type	Memory	Step	Pass/Fail	Test Result	Timer	Parameter 1	Parameter 2
1	DC Withstand	32	1	Pass	Pass	60.0s	0.20KV	0.0microamps
~~2~~	~~AC Withstand~~	~~32~~	~~2~~	~~Fail~~	~~Abort~~	~~0.5s~~	~~1.20KV~~	~~0.000mA~~